

**Search Notes**

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Examiner

Michael J. Hayes

Applicant(s)/Patent under  
Reexamination

LANDAU ET AL.

Art Unit

3767

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(606/116,117 222/129,135,137,82 128/dig.6 81/9.22) updated search; see search history	4/1/2006	MJH